

28A, 60V N-CHANNEL POWER MOSFET

■ DESCRIPTION

The UTC **UFZ34** is an N-channel Power MOSFET, it uses UTC's advanced technology to provide the customers with a minimum on state resistance, high switching speed and low gate charge.

The UTC **UFZ34** is suitable for all commercial-industrial applications, etc.

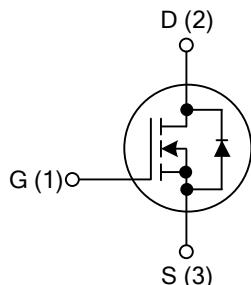
■ FEATURES

- * $R_{DS(ON)} < 0.042\Omega$ @ $V_{GS} = 10V$, $I_D = 17A$

- * High switching speed

- * Low gate charge

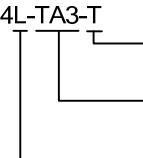
■ SYMBOL



■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UFZ34L-TA3-T	UFZ34G-TA3-T	TO-220	G	D	S	Tube
UFZ34L-TM3-T	UFZ34G-TM3-T	TO-251	G	D	S	Tube
UFZ34L-TN3-R	UFZ34G-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UFZ34L-TA3-T  (1)Packing Type (2)Package Type (3)Lead Free	(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TM3: TO-251, TN3: TO-252 (3) L: Lead Free, G: Halogen Free
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■ ABSOLUTE MAXIMUM RATINGS

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	60	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	Continuous	T _C =25°C	I _D	28
		T _C =100°C		20
	Pulsed (Note 1)		I _{DM}	112
Avalanche Current (Note 1)		I _{AR}	17	A
Avalanche Energy	Single Pulsed (Note 2)	E _{AS}	97	mJ
	Repetitive (Note 1)	E _{AR}	6.8	mJ
Peak Diode Recovery dv/dt (Note 3)		dv/dt	5.0	V/ns
Power Dissipation	T _C =25°C	P _D	68	W
Linear Derating Factor			0.46	W/°C
Junction Temperature		T _J	-55~+175	°C
Storage Temperature Range		T _{STG}	-55~+175	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL CHARACTERISTICS

PARAMETER	SYMBOL	RATING	UNIT
Junction to Ambient	θ _{JA}	62	°C/W
Junction to Case	θ _{JC}	3.3	°C/W

Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. L=670μH, I_{AS}=17A, R_G=25Ω, Starting T_J=25°C.

3. I_{SD}≤17A, di/dt≤200A/μs, V_{DD}≤BV_{DSS}, Starting T_J≤175°C.

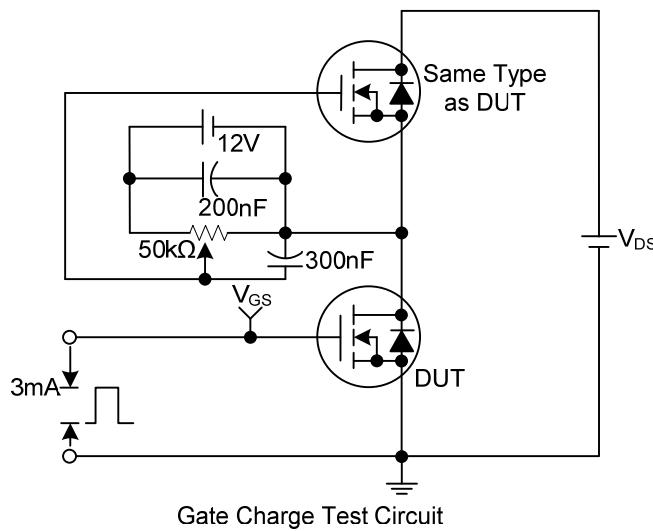
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{\text{GS}}=0\text{V}$	60			V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=60\text{V}, V_{\text{GS}}=0\text{V}$			25	μA
Gate-Source Leakage Current	Forward	$V_{\text{GS}}=+20\text{V}, V_{\text{DS}}=0\text{V}$			+100	nA
	Reverse	$V_{\text{GS}}=-20\text{V}, V_{\text{DS}}=0\text{V}$			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{\text{GS}(\text{TH})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$	2.0		4.0	V
Static Drain-Source On-State Resistance (Note 2)	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_D=17\text{A}$			0.042	Ω
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, f=1.0\text{MHz}$		680		pF
Output Capacitance	C_{OSS}			220		pF
Reverse Transfer Capacitance	C_{RSS}			80		pF
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=48\text{V}, I_D=17\text{A}$ (Note 4)			30	nC
Gate to Source Charge	Q_{GS}				6.7	nC
Gate to Drain Charge	Q_{GD}				12	nC
Turn-ON Delay Time	$t_{\text{D}(\text{ON})}$	$V_{\text{DD}}=30\text{V}, I_D=17\text{A}, R_G=13\Omega,$ $R_D=1.8\Omega$ (Note 2)		5.1		ns
Rise Time	t_R			30		ns
Turn-OFF Delay Time	$t_{\text{D}(\text{OFF})}$			22		ns
Fall-Time	t_F			30		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Body-Diode Continuous Current	I_S				28	A
Maximum Body-Diode Pulsed Current (Note 1)	I_{SM}				100	A
Drain-Source Diode Forward Voltage (Note 2)	V_{SD}	$T_J=25^\circ\text{C}, I_S=17\text{A}, V_{\text{GS}}=0\text{V}$			1.3	V
Body Diode Reverse Recovery Time	t_{RR}	$T_J=25^\circ\text{C}, I_F=17\text{A},$ $dI/dt=100\text{A}/\mu\text{s}$		63	95	ns
Body Diode Reverse Recovery Charge (Note 2)	Q_{RR}			130	200	nC
Forward Turn-On Time	t_{ON}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

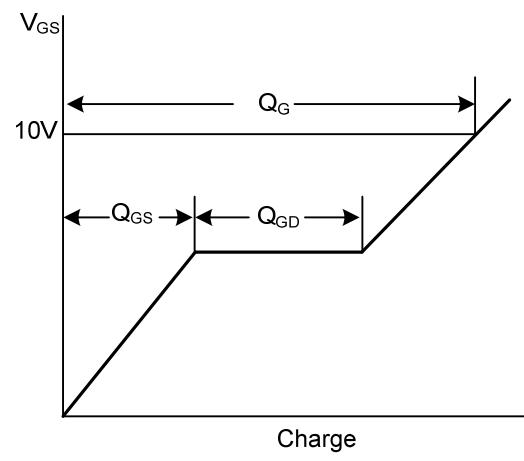
Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature.

2. Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.

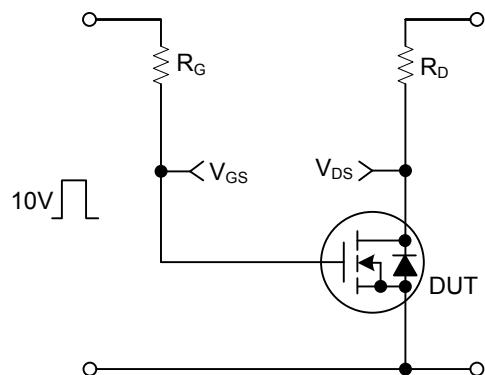
■ TEST CIRCUITS AND WAVEFORMS



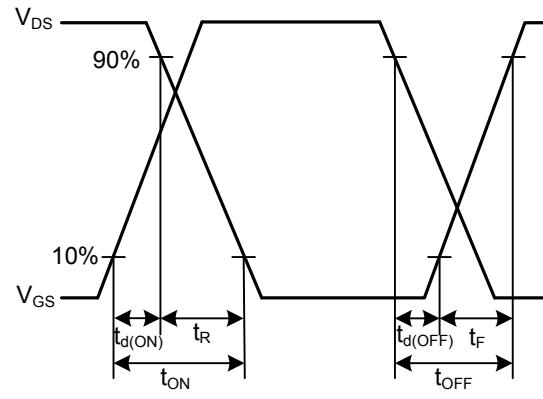
Gate Charge Test Circuit



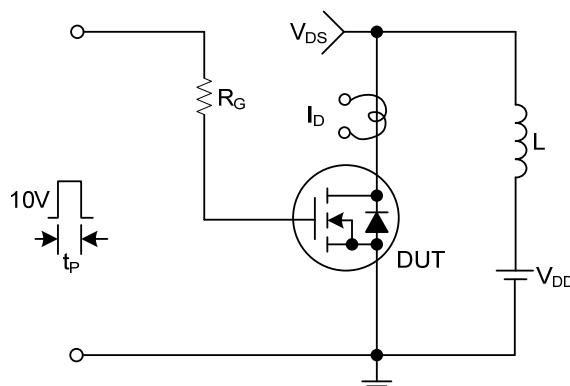
Gate Charge Waveforms



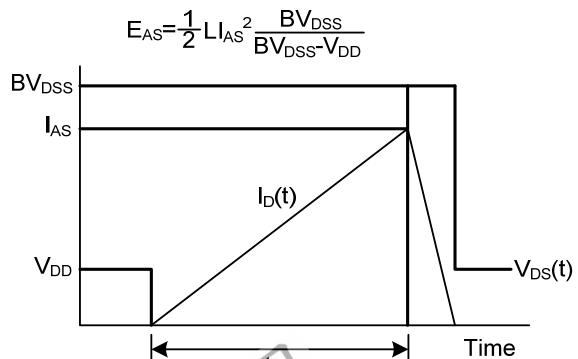
Resistive Switching Test Circuit



Resistive Switching Waveforms

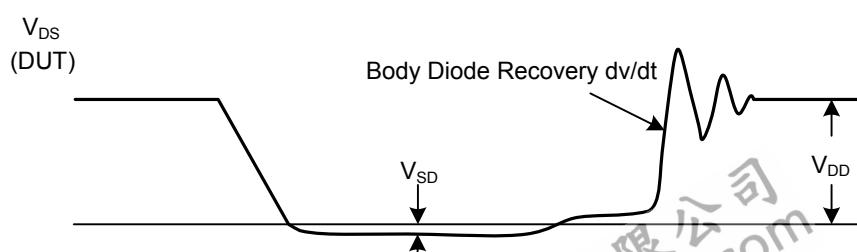
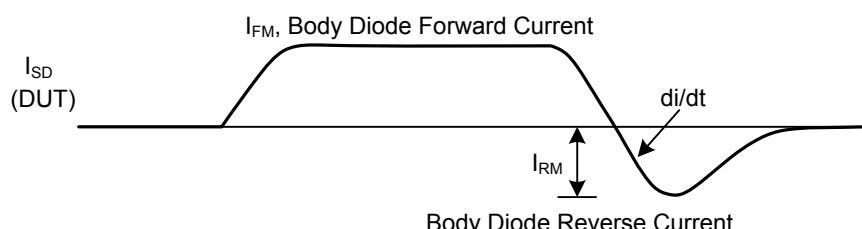
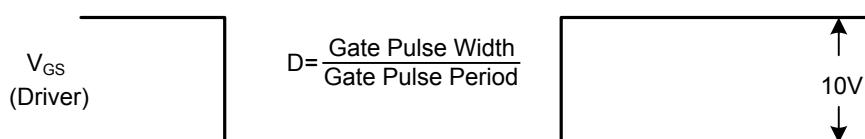
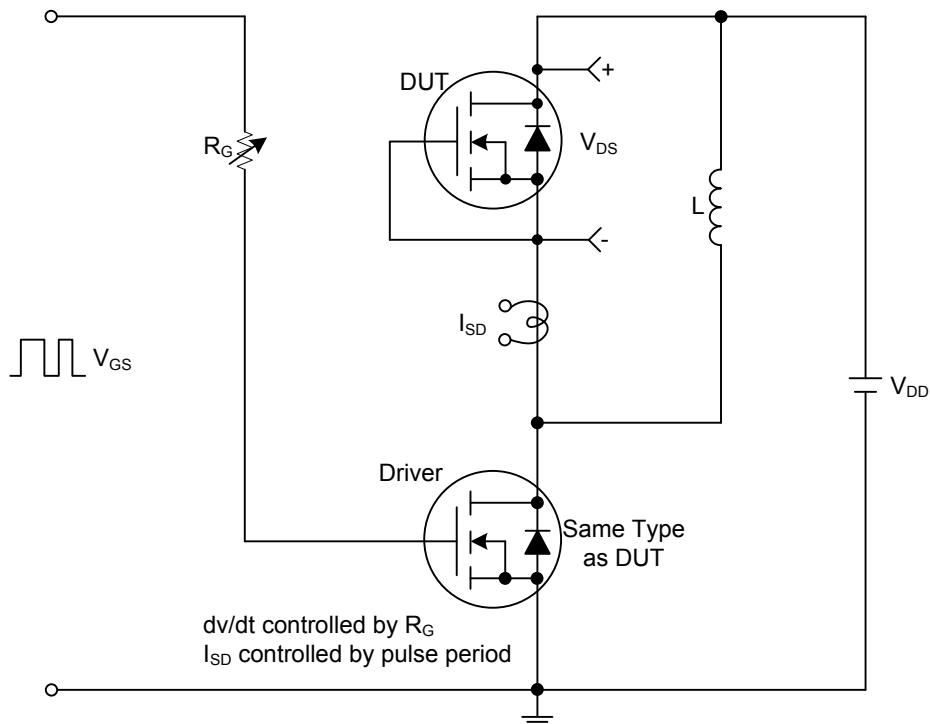


Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

■ TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit and Waveforms

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